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** CONTINUING DATA *****

This application is a CON of PCT/JP05/07120 04/13/2005

** FOREIGN APPLICATIONS *****

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** IF REQUIRED, FOREIGN FILING LICENSE GRANTED **

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35 USC 119(a-d) conditions met	<input checked="" type="checkbox"/> Yes <input type="checkbox"/> No	<input checked="" type="checkbox"/> Met after Allowance tc Initials	JAPAN	6	6
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TITLE

SEMICONDUCTOR WAFER INSPECTION DEVICE AND METHOD

FILING FEE RECEIVED 1430	FEES: Authority has been given in Paper No. _____ to charge/credit DEPOSIT ACCOUNT No. _____ for following:	<input type="checkbox"/> All Fees
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